



DIM1000ECM33-TF000

IGBT Chopper Module

DS6427-1 November 2023 (LN42924)

FEATURES

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- High Current Density Enhanced DMOS SPT
- Isolated AISiC Base with AIN Substrates
- Lead Free Construction

APPLICATIONS

- High Reliability Inverters
- **Motor Controllers**
- **Traction Drives**
- Choppers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM1000ECM33-TF000 is a 3300V, soft punch through n-channel enhancement mode, insulated gate bipolar transistor (IGBT) chopper module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10 us short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

DIM1000ECM33-TF000

Note: When ordering, please use the complete part number

KEY PARAMETERS

VCES		3300V
V _{CE(sat)}	* (typ)	3.2V
l _c	(max)	1000A
I _{C(PK)}	(max)	2000A

^{*} Measured at the auxiliary terminals

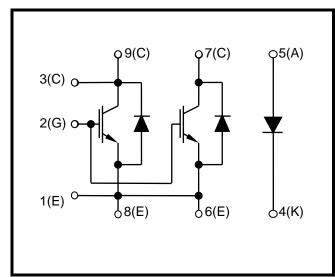


Fig. 1 Circuit configuration



Fig. 2 Package

ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
Vces	Collector-emitter voltage	V _{GE} = 0V	3300	V
V _{GES}	Gate-emitter voltage		±20	V
Ic	Continuous collector current	T _{case} = 110°C	1000	Α
I _{C(PK)}	Peak collector current	1ms, T _{case} = 140°C	2000	Α
P _{max}	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{j} = 150^{\circ}C$	10.4	kW
124	Diode I²t value (IGBT arm)		320	kA ² s
Diode I ² t value (Diode arm)		$V_R = 0$, $t_p = 10$ ms, $T_j = 150$ °C		kA ² s
Visol	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	6000	V
Q_{PD}	Partial discharge – per module	IEC1287, V ₁ = 3500V, V ₂ = 2600V, 50Hz RMS	10	рС

THERMAL AND MECHANICAL RATINGS

Internal insulation material:

Baseplate material:

Creepage distance:

Clearance:

CTI (Comparative Tracking Index):

AIN

AISiC

31mm

20mm

>600

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
R _{th(j-c)}	Thermal resistance – transistor	Continuous dissipation – junction to case	-	-	12	°C/kW
R _{th(j-c)}	Thermal resistance – diode (IGBT arm)	Continuous dissipation – junction to case	ı	-	24	°C/kW
R _{th(j-c)}	Thermal resistance – diode (Diode arm)	Continuous dissipation – junction to case	1	-	24	°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	ı	-	6	°C/kW
_	Junction temperature	Transistor	-	-	150	°C
T _j		Diode	-	-	150	°C
T _{stg}	Storage temperature range	-	-40	-	125	°C
		Mounting – M6	-	-	5	Nm
	Screw torque	Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm

ELECTRICAL CHARACTERISTICS

 T_{case} = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Ices		V _{GE} = 0V, V _{CE} = V _{CES}			4	mA
	Collector cut-off current	V _{GE} = 0V, V _{CE} = V _{CES} , T _{case} = 125°C			60	mA
		V _{GE} = 0V, V _{CE} = V _{CES} , T _{case} = 150°C			100	mA
I _{GES}	Gate leakage current	V _{GE} = ± 20V, V _{CE} = 0V			1	μΑ
V _{GE(TH)}	Gate threshold voltage	Ic = 80mA, V _{GE} = V _{CE}		6.2		V
		V _{GE} = 15V, I _C = 1000A		3.2		V
V _{CE(sat)}	Collector-emitter saturation voltage	V _{GE} = 15V, I _C = 1000A, T _j = 125°C		3.7		V
		V _{GE} = 15V, I _C = 1000A, T _j = 150°C		3.8		V
lF	Diode forward current	DC		1000		Α
I _{FM}	Diode maximum forward current	t _p = 1ms		2000		Α
	Diode forward voltage (IGBT & Diode arm)	I _F = 1000A		2.4		V
V _F		I _F = 1000A, T _j = 125°C		2.5		V
	,	I _F = 1000A, T _j = 150°C		2.4		V
Cies	Input capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 1MHz		170		nF
Qg	Gate charge	±15V Including external C _{ge}		17		μC
Cres	Reverse transfer capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 1MHz		4		nF
	Module inductance	IGBT		15		nΗ
L _M		Diode		25		
Б	Internal resistance	IGBT		135		
R _{INT}		Diode		270		μΩ
SC _{Data}	Short circuit current, I _{SC}	$T_{j} = 150$ °C, $V_{CC} = 2500$ V $t_{p} \le 10 \mu s$, $V_{GE} \le 15$ V $V_{CE (max)} = V_{CES} - L^{*} x dI/dt$ IEC 60747-9		3700		А

Note:

^{*} L is the circuit inductance + L_M

ELECTRICAL CHARACTERISTICS

 $T_{case} = 25$ °C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	I _C = 1000A		2360		ns
t _f	Fall time	$V_{GE} = \pm 15V$		520		ns
Eoff	Turn-off energy loss	$V_{CE} = 1800V$		700		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 2.5\Omega$ $R_{G(OFF)} = 2.2\Omega$		990		ns
tr	Rise time	$C_{ge} = 220 nF$		440		ns
Eon	Turn-on energy loss	Ls ~ 100nH		1200		mJ
Qrr	Diode reverse recovery charge	I _F = 1000A		500		μC
Irr	Diode reverse recovery current	V _{CE} = 1800V		650		Α
Erec	Diode reverse recovery energy	dlϝ/dt = 2700A/μs		650		mJ

T_{case} = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	I _C = 1000A		2540		ns
t f	Fall time	$V_{GE} = \pm 15V$		540		ns
Eoff	Turn-off energy loss	$V_{CE} = 1800V$		1100		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 2.5\Omega$ $R_{G(OFF)} = 2.2\Omega$		935		ns
t _r	Rise time	$C_{ge} = 220nF$		420		ns
Eon	Turn-on energy loss	Ls ~ 100nH		1700		mJ
Qrr	Diode reverse recovery charge	I _F = 1000A		850		μC
Irr	Diode reverse recovery current	V _{CE} = 1800V		775		Α
E _{rec}	Diode reverse recovery energy	dl _F /dt = 2700A/μs		1010		mJ

T_{case} = 150°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	I _C = 1000A		2570		ns
t f	Fall time	$V_{GE} = \pm 15V$		580		ns
E _{OFF}	Turn-off energy loss	$V_{CE} = 1800V$		1200		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 2.5\Omega$ $R_{G(OFF)} = 2.2\Omega$		910		ns
t _r	Rise time	$C_{ge} = 220nF$		430		ns
Eon	Turn-on energy loss	Ls ~ 100nH		1800		mJ
Qrr	Diode reverse recovery charge	I _F = 1000A		1000		μC
Irr	Diode reverse recovery current	V _{CE} = 1800V		825		Α
E _{rec}	Diode reverse recovery energy	dl⊧/dt = 2700A/μs		1200		mJ

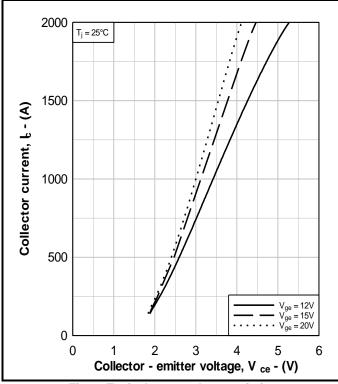


Fig. 3 Typical output characteristics

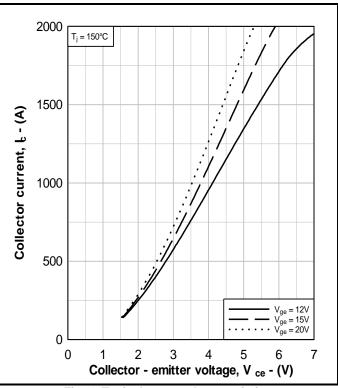


Fig. 4 Typical output characteristics

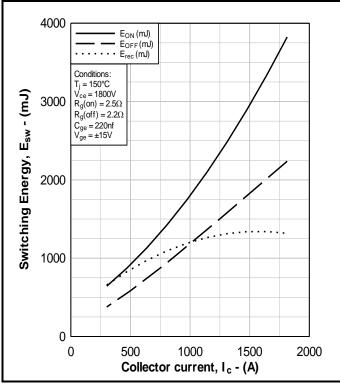


Fig. 5 Typical switching energy vs collector current

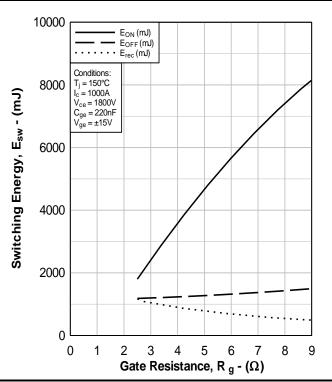


Fig. 6 Typical switching energy vs gate resistance

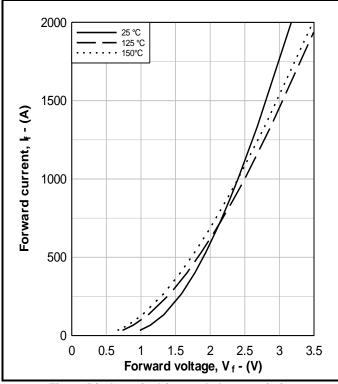


Fig. 7 Diode typical forward characteristics

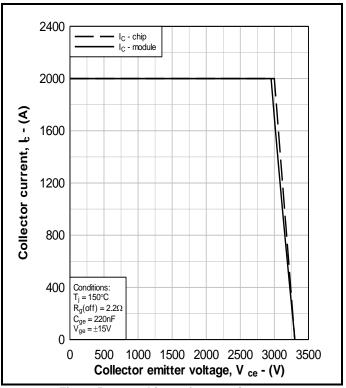


Fig. 8 Reverse bias safe operating area

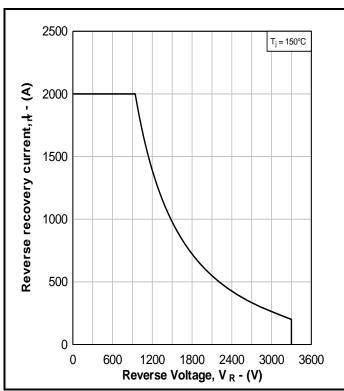


Fig. 9 Diode reverse bias safe operating area

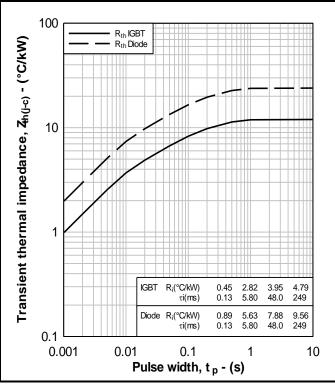


Fig. 10 Transient thermal impedance

PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise.

DO NOT SCALE.

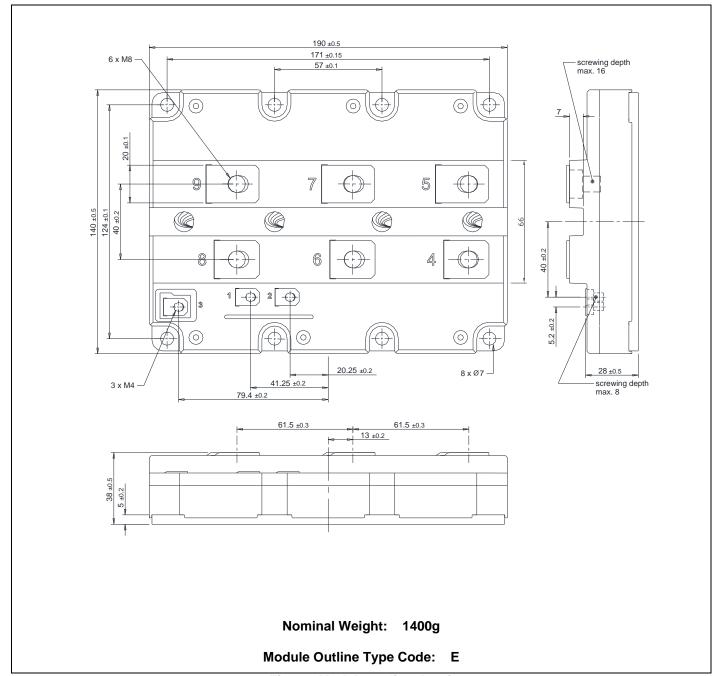


Fig. 11 Module outline drawing

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